Semiconductor Device Type: PT (V7X) 100 TQFP 12x12x1mm Matte Tin			Termination Base Alloy: Copper Alloy (Cu)			Package Homogeneous Materials				JEDEC 97 Product Marking and/or Pkg. Labeling e3
Basic Substance	CAS Number	"Contained In" Sub-Component	% Total Weight	mg/part	ppm	312.02	(mg) Total	Mold Compound	% ot Total Weight	79.8
Silica, vitreous (or fused)	60676-86-0	Mold Compound	67.830	265.215	678,300		Silica, vitreous (or fused)	60676-86-0	85.00	
Epoxy Resin	Trade Secret	Mold Compound Mold Compound	6,943	27.146	69,426		Epoxy Resin	Trade Secret	8.70	
Phenolic Resin	Trade Secret	Mold Compound	4,788	18.721	47,880		Phenolic Resin	Trade Secret	6.00	
Carbon Black	1333-86-4	Mold Compound	0.239	0.936	2.394		Carbon Black	1333-86-4	0.30	
Copper	7440-50-8	Lead Frame	10.000	39.101	100.003		Gaibert Biddit	Total	100.00	J
Nickel	7440-02-0	Lead Frame	0.267	1.043	2,667	41.06	(mg) Total	Lead Frame	% of Total Weight	10.5
Silver	7440-22-4	Lead Frame	0.175	0.685	1.752	41.00	Copper	7440-50-8	95.24	10.5
Silicon	7440-22-4	Lead Frame	0.047	0.185	473		Nickel	7440-02-0	2.54	
Magnesium	7439-95-4	Lead Frame	0.047	0.185	105		Silver	7440-02-0 7440-22-4	2.54	
Silver	7439-95-4	Die Attach	0.555	2.170	5.550		Silver	7440-22-4 7440-21-3	0.45	
	68475-94-5	Die Attach	0.555	0.674				7439-95-4	0.45	
Epoxy resin					1,725		Magnesium			
Copper(II) oxide	1317-38-0	Die Attach	0.023	0.088	225			Total	100.00	
Silicon	7440-21-3	Chip (Die)	7.500	29.325	75,000	2.93	(mg) Total	Die Attach	% of Total Weight	0.75
Copper	7440-50-8	Wire Bond Copper palladium coated (CuPd)	0.197	0.768	1,965		Silver	7440-22-4	74.00	
Palladium	7440-05-3	Wire Bond Copper palladium coated (CuPd)	0.004	0.014	35		Epoxy resin	68475-94-5	23.00	
Tin	7440-31-5	Plating on external leads (pins) - Matte Tin / annealed at 150°C for 1 hour	1.250	4.888	12,500		Copper(II) oxide	1317-38-0	3.00	ļ
TOTALS: 100.000 391.000 1,000,000							Total	100.00		
0.3910 q Total Mass					29.33	Total (mg)	Chip (Die)	% of Total Weight	7.5	
015) and 2002/53/EC (End-of-Life Vehicles (ELV) without exemption (zero) compliance with the above EU Directives has been verified via internal design controls, supplier declarations, and /or analytical test data.						Doped Silicon 7440-21-3 100.00 Total 100.00				
mpliance with the above EU Directives has been verified via inter	nal design contro	Is, supplier declarations, and /or analytical test data.							100.00	
· chemical substance is absent from the list above, the chemical s prporated's knowledge and belief as of the date of this documen	substance is NOT t, there is no cred	an intentional ingredient in the semiconductor device and ble reason to believe that the unavoidable impurity conce				0.78	(mg) Total		100.00 % of Total Weight	0.2
chemical substance is absent from the list above, the chemical s orporated's knowledge and belief as of the date of this documen , is not below the threshold of regulatory concern for any regula Iding compounds used by Microchip meet the UL94 V0 flammabi	substance is NOT t, there is no cred tory scheme work lity standard for p	an intentional ingredient in the semiconductor device and ible reason to believe that the unavoidable impurity conce d-wide.	entration of the	e chemical sul		0.78		Total Wire Bond Copper palladium		0.2
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